

Cite this: *J. Mater. Chem. A*, 2023, **11**, 23566Thermoelectric properties of the aliovalent half-Heusler alloy  $\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$  with intrinsic low thermal conductivity†Blair F. Kennedy,<sup>a</sup> Simon A. J. Kimber,<sup>b</sup> Stefano Checchia,<sup>c</sup> A. K. M. Ashiquzzaman Shawon,<sup>d</sup> Alexandra Zevalkink,<sup>e</sup> Emmanuelle Suard,<sup>f</sup> Jim Buckman<sup>g</sup> and Jan-Willem G. Bos<sup>\*,d</sup>

Using mixtures of aliovalent elements to achieve a valence balanced electronic state is a rapidly emerging area in half-Heusler thermoelectric materials research. Here, we report on  $\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$ , a combination of  $\text{ZnNiSb}$  and  $\text{TiNiSb}$ , which by adjusting the Zn/Ti-ratio can be made p- and n-type, achieving peak  $zT = 0.18$  at 793 K and  $zT = 0.33$  at 700 K, respectively. These promising values are underpinned by a low lattice thermal conductivity,  $\kappa_L = 2.7 \text{ W m}^{-1} \text{ K}^{-1}$  at 340 K, similar for all samples, decreasing to  $1.25 \text{ W m}^{-1} \text{ K}^{-1}$  at 793 K. Transport data reveal similar weighted electronic mobilities for p- and n-type samples, suggesting similar  $zT$  should be possible. For both polarities, a transition to degenerate conduction is observed, superposed on intrinsic semiconducting behaviour with a bandgap  $E_g = 0.4 \text{ eV}$ . Neutron and synchrotron X-ray diffraction experiments, including total scattering, indicate the absence of interstitial metals and do not reveal strong local structural variations. The absence of substantial mass disorder and lattice strain points towards bond disorder as a possible origin for the low  $\kappa_L$ . This work describes a new materials system and provides further insight into the impact of aliovalent alloying in the half-Heusler structure.

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## 1. Introduction

Thermoelectric technology has applications in waste heat recovery, energy scavenging and thermal management.<sup>1–8</sup> The thermoelectric performance of a material is given by its figure of merit,  $zT = (S^2/\rho\kappa)T$ , where  $S$  is the absolute Seebeck coefficient,  $\rho$  is the electrical resistivity and  $\kappa$  the thermal conductivity, which has lattice ( $\kappa_L$ ) and electronic ( $\kappa_E$ ) components, and  $T$  is the absolute temperature.<sup>3</sup> Half-Heusler (HH) alloy materials are leading contenders for application in mid-temperature

power generation applications. In addition to good thermoelectric performance, they satisfy important engineering requirements, including mechanical strength, stability, facile electrical and thermal contacting, and they are based on sustainable raw materials if the use of Hf can be avoided.<sup>9–14</sup> Within the already substantial class of HH materials a new direction has recently emerged, focusing on valence balanced mixtures of aliovalent elements that achieve a semiconducting electron count.<sup>15</sup> This approach greatly expands the number of possible HH materials and has led to a significant new research activity,<sup>15–29</sup> extending to high entropy compositions when mixing >5 components.<sup>30–32</sup> Archetypal HH materials with XYZ composition, such as  $\text{ZrNiSn}$  and  $\text{NbFeSb}$  are characterized by large power factors ( $S^2/\rho = 5\text{--}10 \text{ mW m}^{-1} \text{ K}^{-2}$ ) and high  $\kappa_L = 10\text{--}20 \text{ W m}^{-1} \text{ K}^{-1}$ , reflecting their symmetric “tetrahedral” structure with strong chemical bonds.<sup>14,33–37</sup> The new aliovalent compositions have intrinsically low  $\kappa_L$  (e.g.  $\sim 6.5 \text{ W m}^{-1} \text{ K}^{-1}$  at 340 K for  $\text{TiFe}_{0.5}\text{Ni}_{0.5}\text{Sb}$  compared to  $\sim 15 \text{ W m}^{-1} \text{ K}^{-1}$  for  $\text{TiCoSb}$ ) and modest  $S^2/\rho$  (e.g.  $\sim 1.5 \text{ mW m}^{-1} \text{ K}^{-2}$  for  $\text{TiFe}_{0.5}\text{Ni}_{0.5}\text{Sb}$ ).<sup>16</sup> The origin of this intrinsic low  $\kappa_L$  is not fully explained. Initial work considered ordered variants, *i.e.* a lower symmetry structure with Fe and Ni arranged in a checkerboard pattern.<sup>15</sup> Calculations showed reduced phonon velocities and increased Umklapp scattering, consistent with a low  $\kappa_L$ .<sup>15</sup> However, there is no experimental evidence for ordering of the aliovalent metals in any of the studied systems, and it is unclear

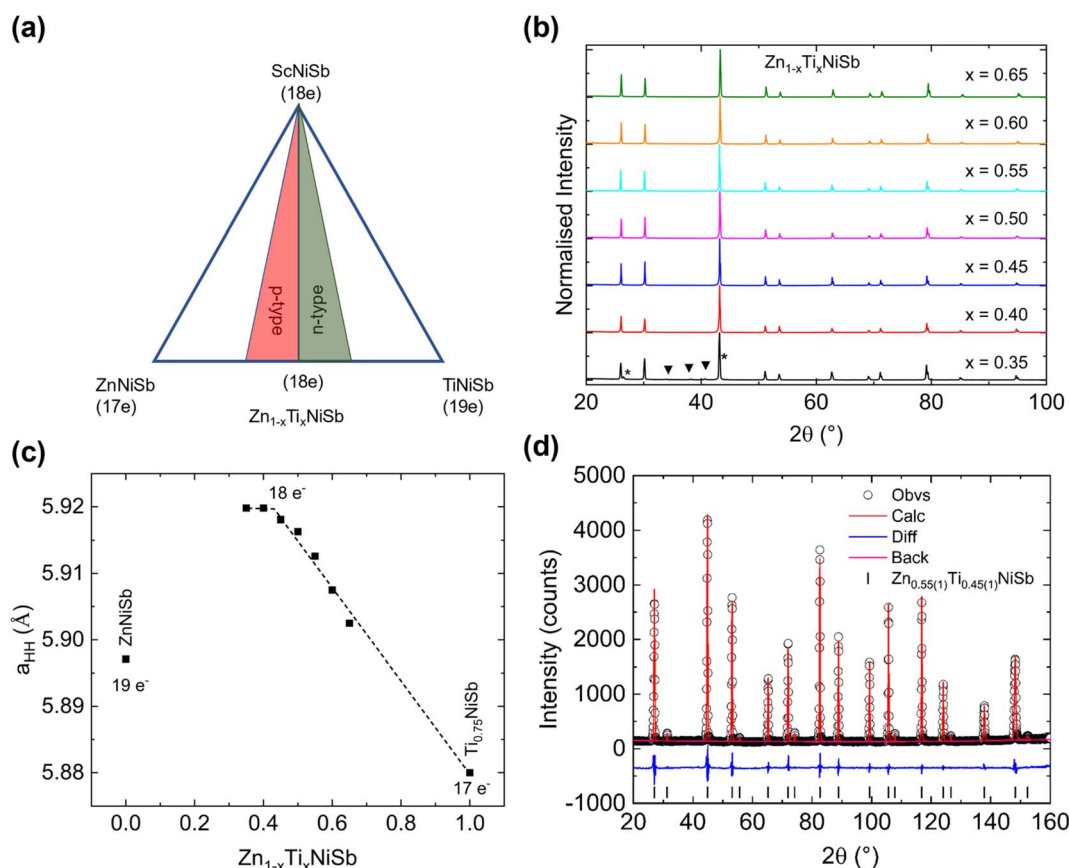
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if the results of these calculations carry over into the real (disordered) materials. The lack of ordering implies that the sometimes-used nomenclature of double (or triple, *etc.*) HHs is something of a misnomer, as noted in the original publication.<sup>15</sup> Mechanical properties and velocity of sound are not markedly different compared to XYZ compositions, indicating that the observed low  $\kappa_L$  and compromised  $S^2/\rho$  are due to disorder that reduces the phonon and electron mean free path.<sup>16,19</sup> The usual contributors to atomic-scale disorder are mass fluctuations and lattice strain due to size differences of the elements present.<sup>38</sup> However, these disorder effects are small for most of the aliovalent compositions as they contain elements with similar mass and size. In some compositions, vacancies and/or interstitials have been observed, and this would cause large disorder,<sup>39–42</sup> but it remains unclear if this occurs for all aliovalent HH alloys.<sup>21,25</sup>

Most work on aliovalent HHs has focused on compositions with mixtures of Y-site elements. In case of  $\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$ , the aliovalent mixing (formal oxidation states of  $\text{Zn}^{2+}$  and  $\text{Ti}^{4+}$ ) occurs on the X-site, which is octahedrally coordinated by Sb.<sup>9</sup> This local structure contrasts with the Y-site, which has 4 X and 4 Z neighbours, each in tetrahedral coordination.<sup>9</sup> To date, two

other X-site aliovalent HH alloys have been investigated. Both contain 17-electron  $\text{MgNiSb}$ , combined with  $\text{TiNiSb}$  (19 electrons) or  $\text{VNiSb}$  (20 electrons) to yield valence balanced 18-electron  $\text{Mg}_{0.5}\text{Ti}_{0.5}\text{NiSb}$  and  $\text{Mg}_{0.67}\text{V}_{0.33}\text{NiSb}$  compositions.<sup>20,25</sup> Both compositions have low  $\kappa_L$  with 340 K values  $\sim 4.5 \text{ W m}^{-1} \text{ K}^{-1}$  for  $\text{Mg}_{0.5}\text{Ti}_{0.5}\text{NiSb}$  and  $\sim 2.5 \text{ W m}^{-1} \text{ K}^{-1}$  for  $\text{Mg}_{0.67}\text{V}_{0.33}\text{NiSb}$ , substantially lower than found for Y-site systems like  $\text{TiFe}_{0.5}\text{Ni}_{0.5}\text{Sb}$ . This suggests that the disorder introduced by aliovalent X-site mixing is stronger than for the Y-site systems. In case of  $\text{Mg}_{1-x}\text{Ti}_x\text{NiSb}$ , peak  $zT \sim 0.4$  is found for both p- ( $x = 0.48$ ) and n-type ( $x = 0.6$ ) compositions at 950 K.<sup>25</sup>  $\text{Mg}_{0.67}\text{V}_{0.33}\text{NiSb}$  has a lower peak  $zT \sim 0.17$  at 750 K, but has not yet benefitted from an optimisation study.<sup>20</sup> The largest  $zT$  values for the aliovalent HH alloys, without additional Hf alloying, are found for  $\text{TiFe}_{1-x}\text{Ni}_x\text{Sb}$  with  $zT = 0.7$  (p-type,  $x = 0.4$ ) and  $zT = 0.5$  (n-type,  $x = 0.6$ ) at 973 K, reflecting a better trade-off between electronic mobility and low  $\kappa_L$ .<sup>16</sup>

$\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$  is an analogue of  $\text{Mg}_{0.5}\text{Ti}_{0.5}\text{NiSb}$  combining 17-electron  $\text{ZnNiSb}$  and 19-electron  $\text{TiNiSb}$  to form a stable 18-electron semiconducting composition. This is schematically illustrated in Fig. 1a, including its relationship to a regular 18-electron XYZ HH alloy,  $\text{ScNiSb}$  in this example. Adjusting the



**Fig. 1** (a) Schematic phase diagram linking 17 electron  $\text{ZnNiSb}$ , 19 electron  $\text{TiNiSb}$  and 18 electron  $\text{ScNiSb}$ . (b) Stacked X-ray powder diffraction datasets for the  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  samples prepared in this study. The \* and ▼ symbols represent graphite and an unknown impurity in the  $x = 0.35$  sample. (c) Evolution of the half-Heusler lattice parameter; linear extrapolation reveals a continuous change towards  $\text{Ti}_{0.8}\text{Ni}_{0.2}\text{Sb}$  indicating that further substitution of Ti is possible and that Ti vacancies are introduced; the plateau in the direction of  $\text{ZnNiSb}$  reveals the limit of Zn solubility under the used synthetic conditions. (d) Rietveld fit to neutron powder diffraction data collected on a  $\text{Ti}_{0.5}\text{Zn}_{0.5}\text{NiSb}$  sample, confirming that Zn/Ti are located on the X-site, and not giving any indication of the presence of interstitial metals.



Zn/Ti ratio can be used to control the carrier polarity, with Zn donating two electrons and Ti four electrons. Stable  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  compositions can be prepared between  $0.35 \leq x \leq 0.65$ . The most significant feature of these materials is the low  $\kappa_L \sim 2.7 \text{ W m}^{-1} \text{ K}^{-1}$  at 340 K, which occurs without substantial mass and size disorder from our diffraction and total scattering data. In terms of electronic properties,  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  shows a transition from semiconducting ( $x \sim 0.5$ ) to degenerately doped behaviour for both n- ( $x > 0.5$ ) and p-type doping ( $x < 0.5$ ). Competitive highest  $zT$  values of 0.18 (793 K) and 0.33 (700 K) are observed for p- and n-type compositions. It is worth noting that  $\text{TiNiSb}$ , the  $x = 1$  end-member of the  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  series, forms with large amounts of Ti vacancies. Based on electron counting,  $\text{Ti}_{0.75}\text{NiSb}$  has 18 valence electrons. Experimentally strongly n-type doped compositions near  $\text{Ti}_{0.8}\text{NiSb}$  are found.<sup>43–45</sup> The large concentration of Ti vacancies strongly impacts on the thermoelectric properties with low  $\kappa_L$  values observed. However, for  $\text{Ti}_{0.8}\text{NiSb}$ , this is likely linked to the large mass disorder caused by the vacancies.

## 2. Results

### 2.1 Phase stability and crystal structure

Fig. 1 gives an overview of the phase behaviour of the  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  samples. Samples were successfully prepared between  $x = 0.35$  (Zn rich) and  $x = 0.65$  (Ti rich), *i.e.* extending 0.15 holes/electrons away from the 18-electron  $x = 0.5$  composition (Fig. 1b). The evolution of the lattice parameter (Fig. 1c) confirms that, at the Zn-rich end,  $x = 0.40$  corresponds to the solubility limit under the used synthetic conditions. At the Ti-rich side, linear extrapolation of the lattice parameter beyond  $x = 0.65$  matches with the reported value for  $\text{Ti}_{0.8}\text{NiSb}$ ,<sup>44</sup> suggesting (1) that larger  $x$  values are accessible and (2) that Ti vacancies are gradually introduced for  $x > 0.5$ . SEM-EDX analysis showed samples to be highly homogeneous with no compositional segregation at the micrometre length scale (Fig. S1 and S2 in the ESI†). Minor Ti impurities occur at grain boundaries, most obvious for the Ti-rich compositions, while Zn-rich samples show slight reaction towards the Ta foil used

for sample containment. Zn-rich samples show less damage after polishing, suggesting that polycrystalline domains are bonded stronger. Overall, SEM-EDX confirms the purity of the prepared samples with compositions in agreement with nominal values (Table S1†). The presence of minor Ti impurities for  $x > 0.5$  is consistent with the gradual introduction of Ti vacancies, as predicted from the lattice parameter evolution (Fig. 1c). Assuming a linear increase of Ti vacancies, our  $x = 0.65$  composition could have a vacancy fraction near 0.04, which is difficult to confirm from site occupancy analysis in Rietveld fits of laboratory X-ray diffraction data. Another outstanding question is the location of Zn in the crystal structure. According to its +2 formal oxidation state and similarity in behaviour to Mg, it is expected to occupy the X-site. However, its location in the periodic table after Ni suggests that it could also be accommodated on the Y-site.<sup>15</sup> Neutron powder diffraction, which offers good scattering contrast between Ti ( $b = -3.4 \text{ fm}$ ), Zn ( $b = 5.68 \text{ fm}$ ), Ni ( $b = 10.3 \text{ fm}$ ) and Sb ( $5.57 \text{ fm}$ ), was used to investigate the distribution of metals in the structure (Fig. 1d). This showed that in a nominal  $x = 0.5$  sample, Zn and Ti occupy the X-site, with the fits indicating a slightly Zn-rich  $\text{Ti}_{0.45(1)}\text{Zn}_{0.55(1)}\text{NiSb}$  composition (Table 1). Attempts to include interstitial metals, vacancies or incorporate site disorder (X-, Y-site swapping) did not lead to improvements to the fit, suggesting that these defects are absent. One notable feature is the order of magnitude larger thermal displacement parameter for the Ti/Zn-site, which could signal structural disorder (Table 1). However, the near null coherent scattering factor for Ti/Zn could also be driving this behaviour by making the site near invisible. Synchrotron X-ray diffraction data does not show this large disorder effect with similar displacement parameters for all sites (Table 1). A final feature of the NPD pattern is the slightly asymmetric peak shape, extending towards higher  $d$ -spacings, which cannot fully be described by the pseudo-Voigt function. This indicates a degree of inhomogeneity, possibly related to short range-clustering of the X-site metals, although no evidence for this was found from the pair distribution function (PDF) analysis below.

Total scattering and PDF analysis is a powerful probe of local structure, looking at distributions of bond distances. This can yield information beyond the average unit cell, *e.g.* the observation of different Ti–Ni and Zn–Ni bond distances, whereas only an average value can be obtained from diffraction. The results from PDF analysis of a  $\text{Zn}_{0.4}\text{Ti}_{0.6}\text{NiSb}$  sample is summarised in Fig. 2. The diffraction pattern can be fitted well by the HH structure with nominal composition (Fig. 2a and Table 1). Trial fits provided no evidence for structural point defects, confirming the absence of interstitials, in agreement with the NPD analysis. The resulting structural model was used to fit the experimental PDF data, yielding good agreement with the observed intensities (Fig. 2b). The absence of peak splitting in the PDF data, *e.g.* due to different Ti–Ni and Zn–Ti bond distances confirms that the local structure is close to the average from the Rietveld analysis. In other words, the local coordination is similar to that expected based on the average structure, within the experimental resolution. The limited X-ray scattering contrast between Zn and Ti means the experiment is

**Table 1** Lattice parameters ( $a$ ), site occupancies (occ), thermal displacement parameters ( $U_{\text{iso}}$ ) and fit statistics for the Rietveld refinements against neutron ( $\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$ ) and synchrotron X-ray ( $\text{Zn}_{0.4}\text{Ti}_{0.6}\text{NiSb}$ ) powder diffraction data

	$\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$ (NPD)	$\text{Zn}_{0.4}\text{Ti}_{0.6}\text{NiSb}$ (SXRD)
$a_{\text{HH}}$ (Å)	5.9186(1)	5.9121(1)
$X_{\text{occ}}$	Zn – 0.55(1) Ti – 0.45(1)	Zn – 0.4 Ti – 0.6
$U_{\text{iso}}$ (Å <sup>2</sup> )	0.031(4)	0.007(1)
$Y_{\text{occ}}$	Ni – 1	Ni – 1
$U_{\text{iso}}$ (Å <sup>2</sup> )	0.0046(2)	0.0043(1)
$Z_{\text{occ}}$	Sb – 1	Sb – 1
$U_{\text{iso}}$ (Å <sup>2</sup> )	0.0029(4)	0.0029(1)
$wR_p$ (%)	7.6	5.9
$R_f$ (%)	4.7	9.5
$R_p$ (%)	5.2	5.6



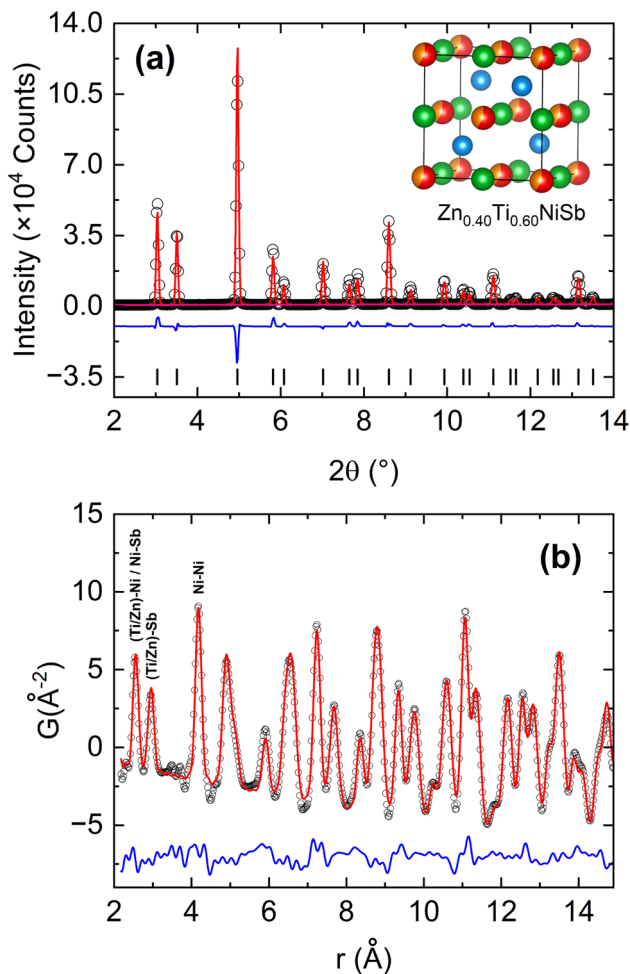


Fig. 2 Synchrotron X-ray total scattering investigation of  $\text{Zn}_{0.4}\text{Ti}_{0.6}\text{NiSb}$ . (a) Rietveld fit to the diffraction dataset, revealing good agreement between the average unit cell structure and the experimental data. (b) Fit to the pair distribution function, which gives additional insight into the local structure, which is adequately described by the average unit cell structure with mixing of Ti and Zn on the X-site without any interstitial metals. The inset in panel (a) shows the structure used to fit both XRD and PDF datasets (Zn/Ti: mixed orange/red; Ni: blue; Sb: green).

not sensitive to picking up evidence of short-range clustering and this may occur in these samples. However, this does not lead to large deviations from the average bond distances.

## 2.2 Electrical transport

The evolution of  $S$ ,  $\rho$  and  $S^2/\rho$  with temperature and composition (at 340 K), split by conduction type are shown in Fig. 3 and 4. The  $x = 0.5$  sample is p-type with  $S_{340\text{K}} = 55 \mu\text{V K}^{-1}$ , with the crossover to n-type behaviour occurring for  $x = 0.55$  (Fig. 4a). Samples close to  $x = 0.5$  are characterised by low  $S$  and bipolar conduction. As the composition moves away from the crossover point, becoming more electron rich,  $S_{340\text{K}}$  initially decreases to  $-115 \mu\text{V K}^{-1}$  for  $x = 0.6$  and then increases for  $x = 0.65$ . The Zn-rich samples ( $x = 0.45$  and  $x = 0.4$ ) are p-type conductors with similar  $S_{340\text{K}} \sim 50 \mu\text{V K}^{-1}$  (Fig. 4a). The highest doped n- and p-type samples have or tend towards metal-like  $\rho(T)$ , as expected for increasing carrier doping

levels. Compositions closer to  $x = 0.5$  have a semiconducting  $\rho(T)$ , consistent with being lightly doped and intrinsic conduction *via* carrier excitation across the bandgap. This significant change in behaviour is illustrated by the rapid drop in  $\rho_{340\text{K}}$  (Fig. 4b) as the composition moves away from  $x = 0.5$ . It can also be seen in the  $\rho_{793\text{K}}/\rho_{340\text{K}}$  resistivity ratio, which changes from values  $<1$  (*i.e.* semiconducting) near  $x = 0.5$  to values approaching or  $>1$  (degenerate system) for higher doped samples (Fig. 4c).

The semiconducting  $\rho(T)$  is not described well by a thermally activated (gapped semiconductor) or variable range hopping model (typical for conduction between localised states in disordered materials at band edges) as shown in Fig. S3.† However, a model allowing for parallel degenerate ( $\rho_{\text{deg}}$ ) and semiconducting ( $\rho_{\text{int}}$ ) channels can describe the data very well. This uses the following expression:<sup>46</sup>

$$\rho_{\text{deg}}(T) = \rho_0 + BT^{-1.5}$$

$$\rho_{\text{int}}(T) = Ae^{\frac{-E_g}{2k_B T}}$$

$$\rho(T) = [(\rho_{\text{deg}}(T))^{-1} + (\rho_{\text{int}}(T))^{-1}]^{-1}$$

Here,  $\rho_0$  is the residual resistivity,  $B$  captures the strength of acoustic phonon scattering,  $E_g$  is the electronic bandgap and  $A$  is a scaling factor. The final fit to  $\rho(T)$  is shown in Fig. 3b and e and the fit parameters are summarised in Table S2.† All data is fitted using a consistent bandgap,  $E_g = 0.39(2)$  eV. In case of the semiconducting compositions, inclusion of  $\rho_0$  is essential to fit the data, but there is little temperature dependence in the degenerate term. The degenerate term dominates the transport in the most highly doped n- and p-type compositions, furthest away from  $x = 0.5$ . The weighted mobility,  $\mu_w = \mu_0 [m_{\text{DOS}}^*(m_e)]^{3/2}$  is a measure of the electronic quality of a thermoelectric material.<sup>47</sup> Here,  $\mu_0$  is the intrinsic carrier mobility and  $m_{\text{DOS}}^*$  is the density of states effective mass, related to the band mass and degeneracy of the bandstructure. The calculated  $\mu_w(T)$  is shown in Fig. S4,† and the 340 K values are shown in Fig. 4d. This reveals that the most highly doped compositions have similar  $\mu_w(T)$ , with the p-types performing slightly better at high temperature. The implication is that both polarities can support similar  $S^2/\rho$ , only requiring optimisation of the doping level. At high temperatures  $\mu_w(T)$  follows an approximate  $T^{-1.5}$  dependence, consistent with acoustic phonon scattering limited charge transport. There is no crossover to grain boundary or ionised impurity scattering, which both have a positive  $T^n$  dependence.<sup>47</sup> The deviation from  $T^{-1.5}$  near room temperature likely reflects the large  $\rho_0$  for these samples (Table S2†). Highly doped p- and n-type materials achieve the best  $S^2/\rho = 0.9 \text{ mW m}^{-1} \text{ K}^{-2}$  at 793 K ( $x = 0.4$ ) and  $1.2 \text{ mW m}^{-1} \text{ K}^{-2}$  at 700 K ( $x = 0.6$ ), respectively.

## 2.3 Thermal transport

The temperature dependence of  $\kappa$ ,  $\kappa_L = \kappa - LT/\rho$  and  $zT$  is given in Fig. 5. All compositions have low total  $\kappa = 2.7\text{--}3.7 \text{ W m}^{-1} \text{ K}^{-1}$  at





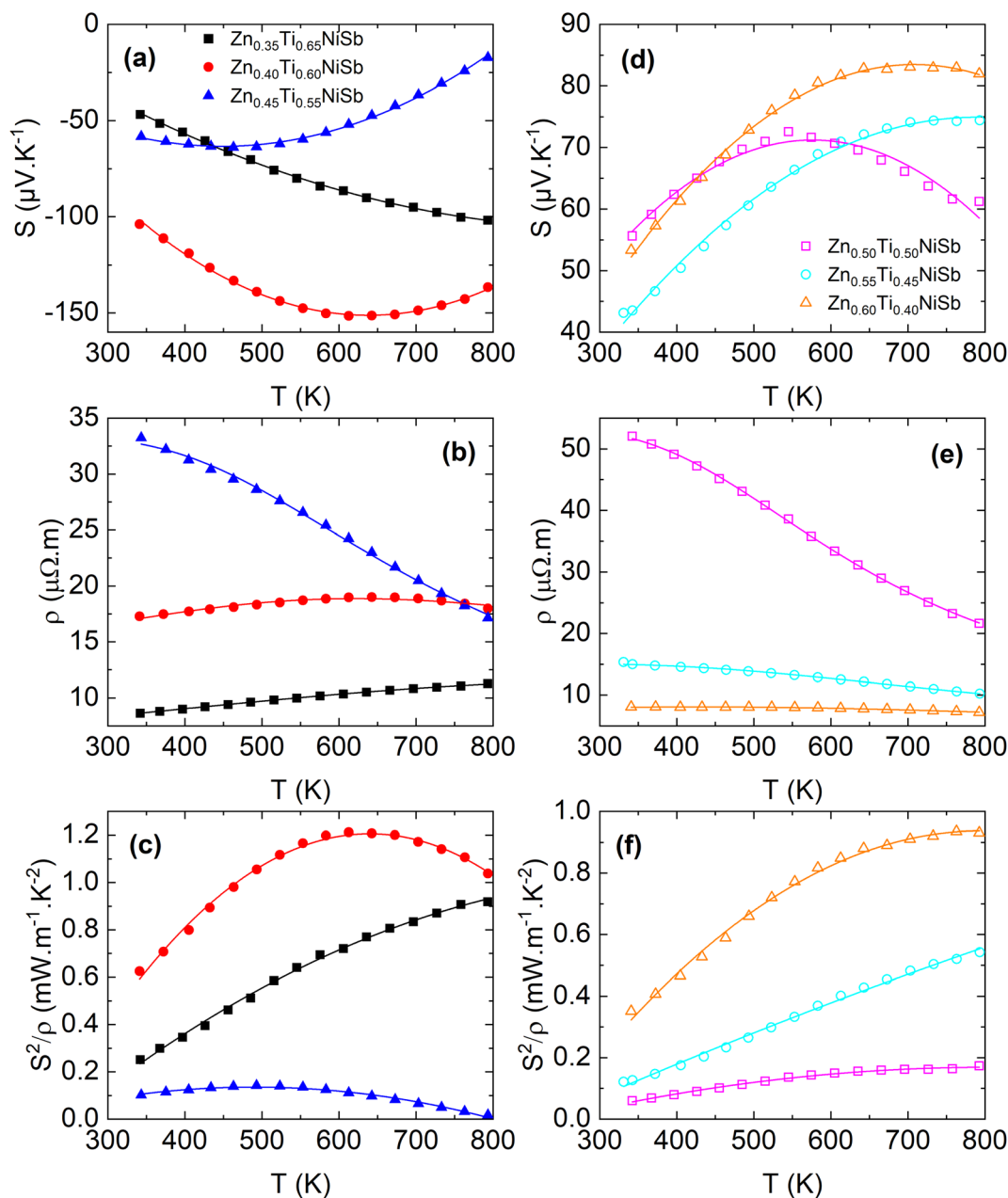


Fig. 3 Temperature dependence of the Seebeck coefficient ( $S$ ), electrical resistivity ( $\rho$ ) and power factor ( $S^2/\rho$ ) split by carrier polarity. Panels (a–c) show data for the n-type and (d–f) for the p-type  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  samples. Solid lines to  $\rho(T)$  are fits as described in the text. Solid symbols are used throughout for n-type samples, open symbols for p-types.

340 K, typically increasing upon heating, due to increasing electronic and bipolar contributions. The only exception is the heavily n-type doped  $x = 0.65$  sample that has a negligible bipolar term (Fig. 5b) and which shows a gradual decrease with temperature. At 340 K, all samples have a low  $\kappa_L = 2.5\text{--}3 \text{ W m}^{-1} \text{ K}^{-1}$  (Fig. 5b), which is remarkable for a HH composition using only first row transition metals, without any heavy alloying elements. The  $\text{Ti}_{0.8}\text{NiSb}$  vacancy HH system has similar low  $\kappa_{L,340\text{K}} = 2\text{--}3 \text{ W m}^{-1} \text{ K}^{-1}$ , but here mass disorder plays a substantial role,<sup>44</sup> unlike in the  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  samples. On heating,  $\kappa_L$  follows a  $T^{-n}$  dependence with  $0.5 \leq n \leq 0.7$  up to 550–600 K, above which bipolar thermal conduction becomes

dominant. This result is consistent with samples near  $x = 0.5$  having a large intrinsic semiconducting component from  $\rho(T)$  fitting. The more highly doped samples have a larger degenerate contribution, and hence an imbalance in p- and n-type carrier concentrations, suppressing the thermal bipolar term, leading to the observation of a very low  $\kappa_L = 1.25 \text{ W m}^{-1} \text{ K}^{-1}$  at 793 K for the  $x = 0.65$  sample. Resonant ultrasound spectroscopy measurements reveal slightly reduced elastic moduli, and reduced transverse ( $v_t$ ) and longitudinal ( $v_l$ ) velocities of sound (Table 2). Compared to  $\text{TiCoSb}$ , a  $\sim 20\%$  reduction in  $v_t$  and  $v_l$  is found, and a  $\sim 10\%$  reduction compared to  $\text{TiFe}_{0.5}\text{Ni}_{0.5}\text{Sb}$ . This reduction partly explains the low  $\kappa_L$  for the  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$



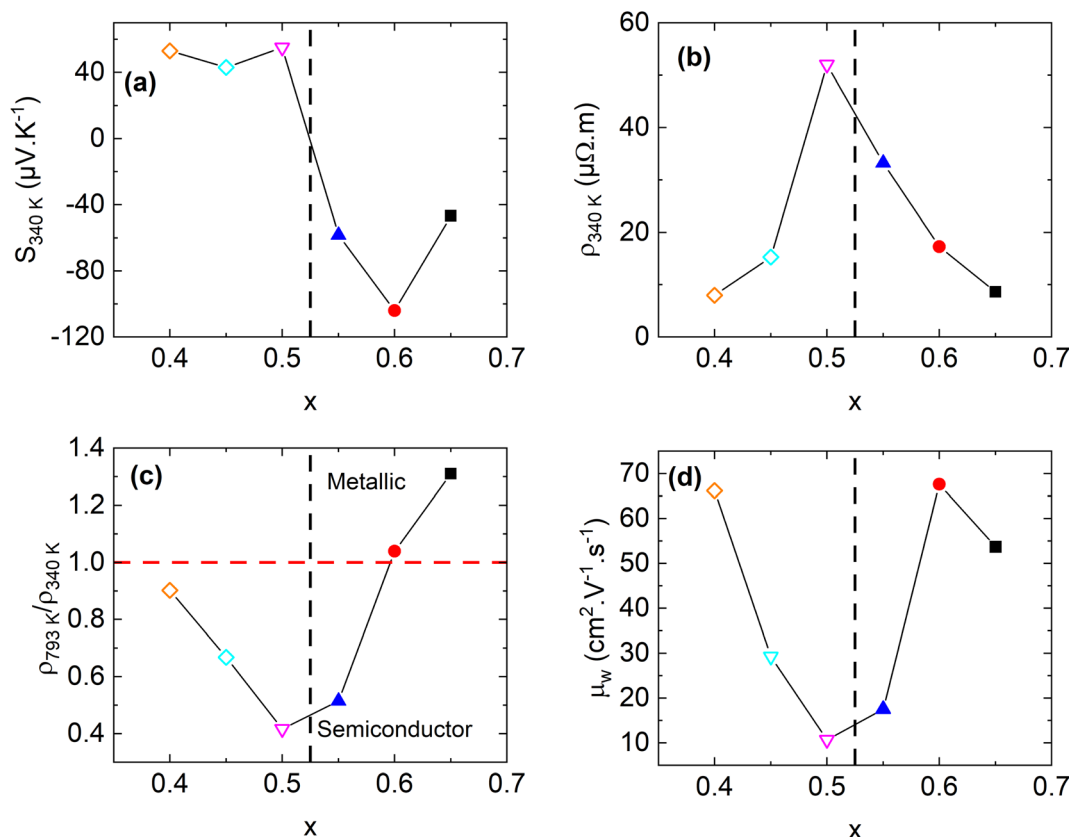


Fig. 4 Composition dependence of (a) the Seebeck coefficient ( $S_{340K}$ ), (b) the electrical resistivity ( $\rho_{340K}$ ), (c) the ratio of the high-to low-temperature resistivity ( $\rho_{793K}/\rho_{340K}$ ) and (d) the weighted mobility ( $\mu_w$ ) for the  $Zn_{1-x}Ti_xNiSb$  samples. The black dashed line corresponds to the approximate p-to n-type transition.

samples (*i.e.* from  $15 W m^{-1} K^{-1}$  for  $TiCoSb$  to  $11 W m^{-1} K^{-1}$ ) but is not sufficient to explain it fully. As was the case for the other aliovalent HH materials, the low  $\kappa_L$  is therefore not fully explained by a reduced  $v_t$  and  $v_l$  but has to be partially attributed to additional channels causing phonon scattering, linked to the mixing of aliovalent elements.

The  $zT$  values achieved in these materials compare well to other aliovalent HH compositions investigated. A peak n-type  $zT = 0.33$  at 700 K was for  $Zn_{0.4}Ti_{0.6}NiSb$  and for the p-types,  $zT = 0.18$  at 793 K was found in  $Zn_{0.6}Ti_{0.4}NiSb$  (Fig. 5c). Hence, both best performing compositions occur 0.1 hole/electrons away from the stable 18 valence electron count of the  $x = 0.5$  composition. Compared to the  $TiFe_{1-x}Ni_xSb$  system, our samples have somewhat lower  $S^2/\rho$  but also lower  $\kappa_L$  values, enabling similar  $zT$  values, when comparing like-for-like in terms of operating temperature. The lower  $S^2/\rho$  and  $\kappa_L$  suggest that there is a stronger “disorder” effect in these X-site aliovalent materials that affects both carrier and phonon lifetime.

### 3. Discussion

We have successfully prepared a new X-site aliovalent HH materials system based on a 50:50 mixture of  $ZnNiSb$  and  $TiNiSb$ . We find an appreciable range of stability in the  $Zn_{1-x}Ti_xNiSb$  series, extending from  $0.4 \leq x \leq 0.65$ . The solid-solution towards  $x = 1$  is readily accessible, while the

boundary for Zn-rich ( $x = 0.4$ ) appears to be a hard limit. This difference in response is related to the reducing electron count, below 18 for  $x < 0.5$ . This destabilises the HH structure, despite the existence of stable  $ZnNiSb$ . For  $x < 0.5$ , there may be a miscibility gap between metallic ( $ZnNiSb$ ) and semi-conducting (close to  $x = 0.5$ ) HH structures. In principle higher synthesis temperature can be used to extend the solubility limit, but this is limited by the low sublimation temperature of Zn. For  $x > 0.5$ , the stable end-member is the  $Ti_{0.8}NiSb$  composition with intrinsic Ti vacancies,<sup>44</sup> which is an 18-electron composition. The  $x = 0.5$  to  $x = 1$  line therefore connects two stable semiconducting HH phases, removing any electronic driving force for immiscibility. Globally the thermoelectric response follows the electron count of the materials with  $x = 0.5$  showing intrinsic semiconducting behaviour, transitioning to degenerate p- and n-type conduction for  $x < 0.5$  (Zn rich) and  $x > 0.5$  (Ti rich). All samples are characterised by relatively low  $\mu_w$ ,  $S^2/\rho$  and  $\kappa_L$ , as is typical for aliovalent HH compositions. A comparison of the measured  $\kappa_L$  and  $zT$  with selected literature samples is given in Fig. 6. This confirms that these materials possess very low  $\kappa_L$ , only matched by  $Mg_{0.67}V_{0.33}NiSb$ , another X-site aliovalent system. As already noted, the  $Ti_{0.8}NiSb$  end-member with intrinsic vacancies also has comparable low  $\kappa_L$ ,  $= 2-3 W m^{-1} K^{-1}$ .<sup>44</sup> This shows that there are two routes to achieve low  $\kappa_L$  without using heavy alloying elements.<sup>14</sup> Both involve the X-site and involve either using mixtures of aliovalent elements (*e.g.*



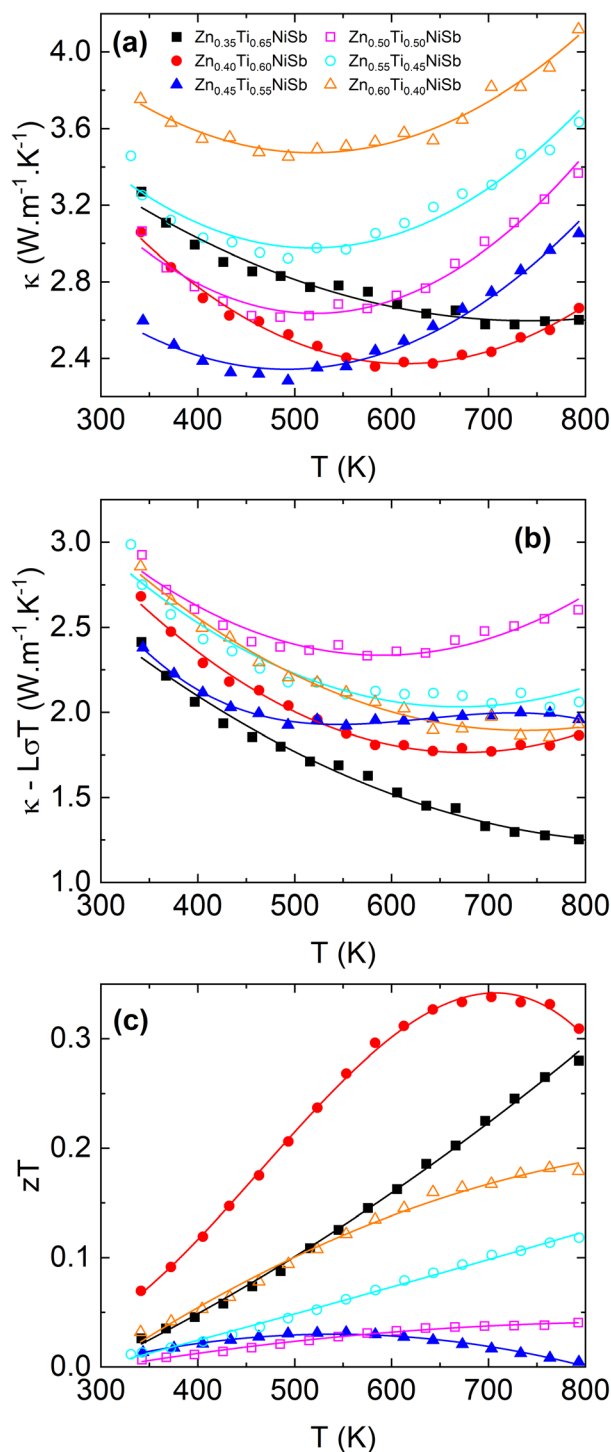


Fig. 5 Thermal properties and figure of merit of the  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  series. Temperature dependence of (a) total thermal conductivity ( $\kappa$ ), (b) lattice thermal conductivity ( $\kappa_L = \kappa - L\sigma T$ ) and (c) dimensionless figure of merit  $zT$ .

Zn/Ti, Mg/Ti or Mg/V) or creating vacancies. In case of X-site vacancies, a large part of the  $\kappa_L$  reduction is likely to be linked to mass disorder, but the bond disorder that is important in the aliovalent systems may well play a role in the vacancy compositions. The  $zT$  values of  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  are competitive with

other aliovalent HH materials systems, considering the temperature at which they occur.

The description of electronic and thermal transport in these aliovalent HH compositions is not yet well understood. Intuitively, mixing aliovalent elements with different orbital energies will lead to a degree of inherent disorder in the electronic structure. This disorder is expected to reduce carrier mobility, consistent with the low values for  $\mu_w$  and  $S^2/\rho$ . Similarly, there is a large suppression of  $\kappa_L$  that is also related to a disorder effect. Analysis of the PDF from synchrotron X-ray total scattering reveals that the local structure for  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  is not substantially different from the average structure. This means that there are no large differences in bond distances (e.g. Zn–Ni versus Ti–Ni) that might give rise to a large lattice strain effect. In addition, there is no evidence for other point defects, such as interstitials, leaving the origin of the low  $\kappa_L$  unresolved. On balance it seems likely that the low  $\kappa_L$  has to be related to a form of bond/electronic disorder that is introduced by the mixing of aliovalent Zn and Ti. For example, the slightly reduced elastic moduli may reflect a mixture of stronger and weaker bonds (e.g. Ti–Ni versus Zn–Ni) that leaves the average  $\nu_l$  and  $\nu_t$  largely unaffected ( $\nu_l$  and  $\nu_t$  are governed by long wavelength phonons) but would cause substantial local bond disorder. If this manifested itself similar to lattice strain, then a 10–20% bond strength mismatch could substantially reduce  $\kappa_L$ . The absence of a clear compositional dependence of  $\kappa_L$  also points towards bond disorder, as lattice strain is known to remain large over a broad composition range near the maximum alloyed ( $x = 0.5$ ) composition.<sup>38</sup> Further investigation of the local structure in these materials, e.g. using high annular dark field imaging in scanning transmission electron microscopy, and modelling beyond the periodic electron and phonon bandstructure, is needed to elucidate the microscopic origin for low mobilities and thermal conductivity.

To conclude, we have investigated the structure and properties of a new aliovalent HH materials system based on mixing 17-electron ZnNiSb and 19-electron TiNiSb. These materials show promising thermoelectric performance in both polarities, tuneable by adjusting the Zn/Ti ratio, offering the possibility of devices with n- and p-type legs of nearly identical composition. Understanding the electrical and thermal transport in aliovalent HH materials is a vital next step for rational design of further performance improvements.

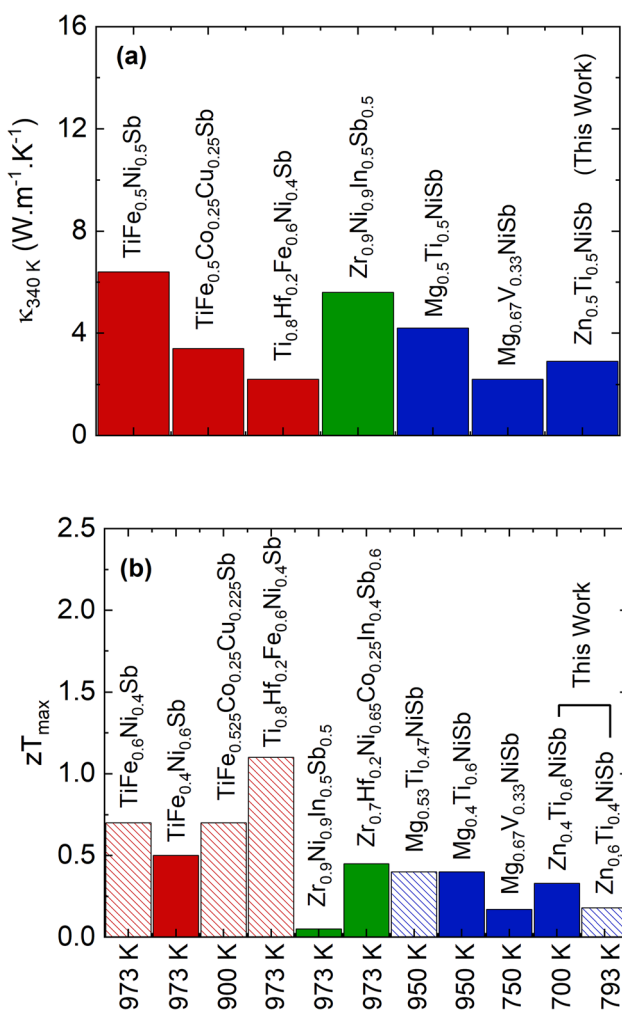
## 4. Experimental

$\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  ( $0.35 \leq x \leq 0.65$ ) samples were prepared on a 5 g scale by solid-state reaction of elemental powders purchased from Alfa Aesar and Merck Scientific of  $\geq 99.99\%$  purity. The powders were mixed with an agate mortar and pestle for  $\sim 20$  minutes, then cold pressed into  $\sim 13$  mm diameter disks. The disks were cut in half using bolt cutters, wrapped in tantalum foil, sealed in evacuated silica ampoules, and annealed for 48 hours at 1073 K, followed by annealing at 1123 K for 48 hours. This two-step profile was chosen to minimise Zn loss due to sublimation. The annealed pellets were ball milled for 30 minutes to produce a fine powder. The powders were hot-



**Table 2** Elastic properties for  $\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$  from resonant ultrasound spectroscopy. RUS determines elastic moduli, from which the tabulated values are calculated.<sup>56</sup> Data from the literature is based on measured velocity of sound data, from which elastic moduli are calculated<sup>14</sup>

	$\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$	$\text{Ti}_{0.8}\text{NiSb}^{44}$	$\text{TiFe}_{0.5}\text{Ni}_{0.5}\text{Sb}^{16}$	$\text{TiCoSb}^{16}$
Longitudinal sound velocity, $v_l$ ( $\text{m s}^{-1}$ )	4720	5301	5300	5750
Shear sound velocity, $v_t$ ( $\text{m s}^{-1}$ )	2623	2873	3060	3230
Average sound velocity, $v_s$ ( $\text{m s}^{-1}$ )	2921	3206	3397	3594
Shear modulus, $G$ (GPa)	47.3	59	68	78
Bulk modulus, $B$ (GPa)	90.2	123	114	144
Young's modulus, $E$ (GPa)	121	153	170	198
Debye temperature, $\theta_D$	324	360	376	401
Poisson ratio, $\nu$	0.28	0.29	0.25	0.27
Grüneisen parameter, $\gamma$	1.66	1.72	1.5	1.6



**Fig. 6** Comparison of (a)  $\kappa_L$  at 340 K and (b) largest  $zT$  values for selected aliovalent half-Heusler compositions. Red histogram bars are for  $\text{XY}_{0.5}\text{Y}'_{0.5}\text{Z}$  compositions, green bars are for  $\text{XYZ}_{0.5}\text{Z}'_{0.5}$  compositions and blue bars are for  $\text{X}'_{0.5}\text{X}''_{0.5}\text{YZ}$  compositions. Hatched (solid) indicates p-type (n-type) samples. Data taken from:  $\text{TiFe}_{1-x}\text{Ni}_x\text{Sb}/\text{Ti}_{0.8}\text{Hf}_{0.2}\text{Fe}_{0.6}\text{Ni}_{0.4}\text{Sb}$ ,<sup>16</sup>  $\text{TiFe}_{0.5+x}\text{Co}_{0.25}\text{Cu}_{0.25-x}\text{Sb}$ ,<sup>24</sup>  $\text{Zr}_{0.9}\text{Ni}_{0.9}\text{In}_{0.5}\text{Sb}_{0.5}/\text{Zr}_{0.7}\text{Hf}_{0.2}\text{Ni}_{0.65}\text{Co}_{0.25}\text{In}_{0.4}\text{Sb}_{0.6}$ ,<sup>21</sup>  $\text{Mg}_{0.5\pm0.5x}\text{Ti}_{0.5\pm0.5x}\text{NiSb}$ ,<sup>25</sup> and  $\text{Mg}_{0.67}\text{V}_{0.33}\text{NiSb}$ .<sup>20</sup>

pressed using an in-house apparatus for 20 minutes at 1123 K with an applied pressure of 80 MPa, yielding densities  $\geq 97\%$  for all hot-pressed disks (Table S3†). An additional  $\text{Ti}_{0.5}\text{Zn}_{0.5}\text{NiSb}$

sample was prepared for Neutron powder diffraction (NPD), with the analysis carried out on a pulverized annealed pellet. All manipulation of powders was done in an argon filled glovebox to prevent exposure to oxygen and moisture.

All samples were initially characterized using powder X-ray diffraction (XRD). Data was collected over 30 minutes using a Malvern Panalytical Empyrean diffractometer, with  $\text{Cu } K_{\alpha 1}$  and  $K_{\alpha 2}$  radiation. Room temperature NPD data was collected on  $\sim 3.5$  g of finely ground powder, on the D2B instrument, ILL, Grenoble, France. Rietveld fitting of XRD and NPD data were carried out using the General Structure Analysis System II (GSAS-II) suite of programs, whilst qualitative peak matching was carried out using the Malvern Panalytical Highscore Plus software and the ICDD database.<sup>50,51</sup>

Scanning electron microscopy (SEM) of the hot pressed  $\text{Zn}_{1-x}\text{Ti}_x\text{NiSb}$  disks was performed using a Quanta 650 FEG SEM, equipped with an Oxford Instruments X-max 150 mm detector for EDX spectroscopy. Prior to measurements, all samples were polished first with SiC sandpaper, then with subsequent 15  $\mu\text{m}$ , 5  $\mu\text{m}$  and 1  $\mu\text{m}$  diamond polish pastes to produce a reflective mirror finish. Polished surfaces were thoroughly washed with propan-1-ol to remove any SiC or diamond paste residue. Quantitative analysis of selected areas was performed using the Oxford Instruments Aztec Large Area Maps software.

Total scattering synchrotron X-ray data was collected on the ID15A beamline<sup>52</sup> at the ESRF (European Synchrotron Research Facility, Grenoble, France) using a Dectris Pilatus 2 M CdTe detector. X-ray energy was 68.5 keV (wavelength 0.1810  $\text{\AA}$ ) and sample-detector distance 185.0 mm. Detector images were averaged and azimuthally integrated using pyFAI<sup>53</sup> and the resulting integrated intensities were converted to PDF using GudrunX.<sup>54</sup> Fitting of the XRD dataset was carried out using the GSAS-II software, whilst the PDF fits were undertaken using the PDFfit2 and PDFGui software.<sup>55</sup>

The electrical resistivity  $\rho$  and absolute Seebeck coefficient  $S$  were measured using a Linseis LSR-3 instrument on bar-shaped specimens ( $\sim 1.5 \times 2 \times 10 \text{ mm}^3$ ), under a static He atmosphere. The thermal diffusivity  $\alpha$  was measured using a Linseis LFA-1000 laser flash instrument on hot-pressed disks of  $\sim 13$  mm diameter and  $\sim 1.5$  mm thickness, under dynamic vacuum conditions. The thermal conductivity  $\kappa$  was then calculated from the equation  $\kappa = \alpha C_p \rho$ , with  $C_p$  the specific heat of the





nominal composition estimated from the Dulong Petit Law and  $\rho$  the disk density obtained using the Archimedes method (Table S3†).

Resonance ultrasound spectroscopy (RUS) was used to measure the natural frequencies of the  $\text{Zn}_{0.5}\text{Ti}_{0.5}\text{NiSb}$  sample using a RUS008 system.<sup>56</sup> The spectrum was collected using the open-source RUSpy software. A parallelepiped sample of dimensions  $4.7 \times 5.8 \times 1.3 \text{ mm}^3$  was used to measure the spectrum. An isotropic model was used to calculate the independent elastic constants C11 and C44 from the spectrum using the RusCal program, which implements an inverse numerical analysis.<sup>57</sup>

## Data availability

The research data underpinning this publication can be accessed at <https://doi.org/10.17630/b9b0eaac-bd76-4ac9-8455-af7c1b735de1>.<sup>58</sup>

## Author contributions

Materials synthesis, data acquisition and analysis, manuscript writing – original draft (B. F. K.); data acquisition and analysis (S. A. J. K., S. C., E. S., A. K. M. A. S., A. Z., J. B.), Conceptualisation, funding, project supervision, manuscript writing - review & editing (J. -W. G. B.).

## Conflicts of interest

There are no conflicts of interest to declare.

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